

Abstract Submitted  
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**Resistivity of Nickel Thin Films**<sup>1</sup> MICHAEL MAYNARD, Dixie State University, JAMESON CURTIS, Dixie High School, SAMUEL TOBLER, Dixie State University — As metal films get thinner, their resistivity increases. We study this phenomenon using nickel films. The nickel films are made in a vacuum system with pressures below  $10^{-7}$  Torr. A nickel filament is heated to 1200C to sublime the nickel onto our glass substrate. A four-point measuring probe was used to measure voltage drops across the film at known currents. This gave a sheet resistance. Thickness of the thin films was verified by images on a scanning electron microscope. Thicknesses varied from 40 nm – 255 nm. Resistivity of films were calculated to be between 22 - 147  $\Omega$  nm. A graph of resistivity vs thickness will be presented and discussed on this poster.

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